
HM514265D Series

HM51S4265D Series

262144-word × 16-bit Dynamic RAM

HITACHI

ADE-203-581A (Z)

Rev. 1.0

Nov. 28, 1996

Description

The Hitachi HM51(S)4265D Series is a CMOS dynamic RAM organized 262,144-word × 16-bit. HM51(S)4265D Series has realized higher density, higher performance and various functions by employing 0.8 μm CMOS process technology and some new CMOS circuit design technologies. The HM51(S)4265D Series offers Extended Data Out (EDO) Page Mode as a high speed access mode. Multiplexed address input permits the HM51(S)4265D to be packaged in standard 400-mil 40-pin plastic SOJ and standard 400-mil 44-pin plastic TSOPII. Internal refresh timer enables HM51S4265D Series self refresh operation.

Features

- Single 5 V (±5%) (HM51(S)4265D-5/6R)
(±10%) (HM51(S)4265D-6/7/8)
- Access time: 50 ns/60 ns/70 ns/80 ns (max)
- Power dissipation
 - Active mode: 945 mW/945 mW/990 mW/825 mW/715 mW (max)
 - Standby mode: 10.5 mW (max) (HM51(S)4265D-5/6R)
11 mW (max) (HM51(S)4265D-6/7/8)
1.05 mW (max) (L-version) (HM51(S)4265DL-5/6R)
1.1 mW (max) (L-version) (HM51(S)4265DL-6/7/8)
- EDO page mode capability
- 512 refresh cycles : 8 ms
128 ms (L-version)
- 2 variations of refresh
 - $\overline{\text{RAS}}$ -only refresh
 - $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh
- $2\overline{\text{CAS}}$ -byte control
- Battery backup operation (L-version)
- Self refresh operation (HM51S4265D Series)

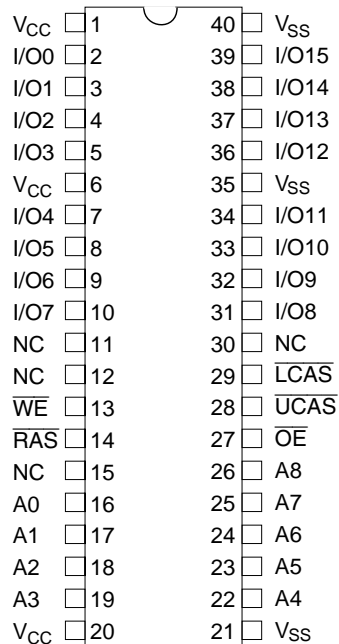
HM514265D Series, HM51S4265D Series

Ordering Information

| Type No. | Access time | Package |
|------------------|-------------|---|
| HM514265DJ-5 | 50 ns | 400-mil 40-pin plastic SOJ (CP-40D) |
| HM514265DJ-6 | 60 ns | |
| HM514265DJ-6R | 60 ns | |
| HM514265DJ-7 | 70 ns | |
| HM514265DJ-8 | 80 ns | |
| HM514265DLJ-5 | 50 ns | |
| HM514265DLJ-6 | 60 ns | |
| HM514265DLJ-6R | 60 ns | |
| HM514265DLJ-7 | 70 ns | |
| HM514265DLJ-8 | 80 ns | |
| HM51S4265DJ-5 | 50 ns | |
| HM51S4265DJ-6 | 60 ns | |
| HM51S4265DJ-6R | 60 ns | |
| HM51S4265DJ-7 | 70 ns | |
| HM51S4265DJ-8 | 80 ns | |
| HM51S4265DLJ-5 | 50 ns | |
| HM51S4265DLJ-6 | 60 ns | |
| HM51S4265DLJ-6R | 60 ns | |
| HM51S4265DLJ-7 | 70 ns | |
| HM51S4265DLJ-8 | 80 ns | |
| HM514265DTT-5 | 50 ns | 400-mil 44-pin plastic TSOPII (TTP-44/40DB) |
| HM514265DTT-6 | 60 ns | |
| HM514265DTT-6R | 60 ns | |
| HM514265DTT-7 | 70 ns | |
| HM514265DTT-8 | 80 ns | |
| HM514265DLTT-5 | 50 ns | |
| HM514265DLTT-6 | 60 ns | |
| HM514265DLTT-6R | 60 ns | |
| HM514265DLTT-7 | 70 ns | |
| HM514265DLTT-8 | 80 ns | |
| HM51S4265DTT-5 | 50 ns | |
| HM51S4265DTT-6 | 60 ns | |
| HM51S4265DTT-6R | 60 ns | |
| HM51S4265DTT-7 | 70 ns | |
| HM51S4265DTT-8 | 80 ns | |
| HM51S4265DLTT-5 | 50 ns | |
| HM51S4265DLTT-6 | 60 ns | |
| HM51S4265DLTT-6R | 60 ns | |
| HM51S4265DLTT-7 | 70 ns | |
| HM51S4265DLTT-8 | 80 ns | |

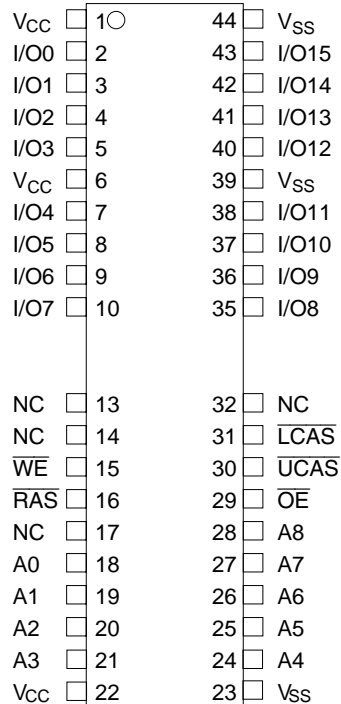
Pin Arrangement

HM514265DJ/DLJ Series
HM51S4265DJ/DLJ Series



(Top view)

HM514265DTT/DLTT Series
HM51S4265DTT/DLTT Series

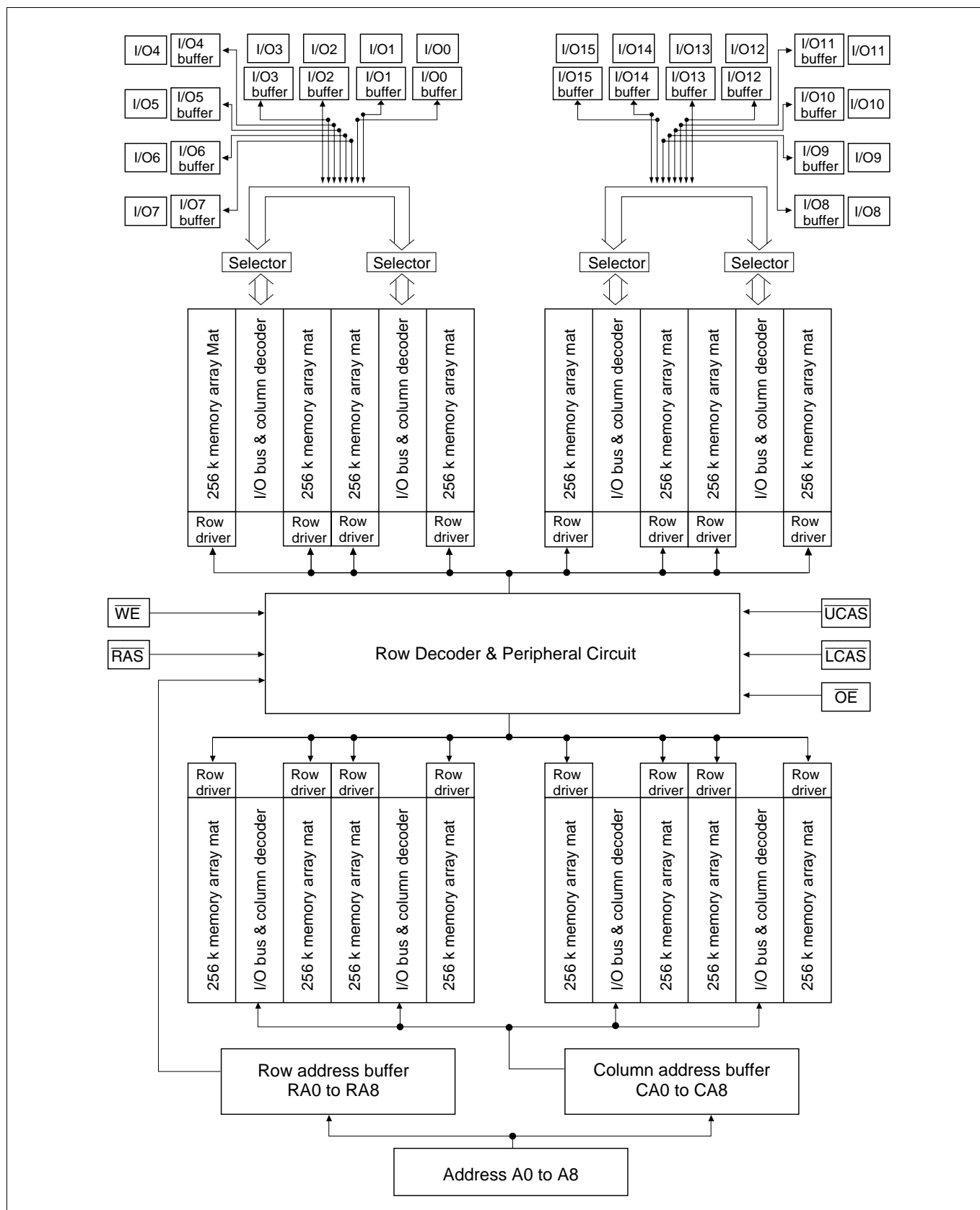


(Top view)

Pin Description

| Pin name | Function |
|-----------------|--|
| A0 to A8 | Address input — Row/Refresh address A0 to A8 — Column address A0 to A8 |
| I/O0 to I/O15 | Data-in/data-out |
| RAS | Row address strobe |
| UCAS, LCAS | Column address strobe |
| WE | Read/write enable |
| OE | Output enable |
| V _{CC} | Power supply |
| V _{SS} | Ground |
| NC | No connection |

Block Diagram



Operation Mode

The HM51(S)4265D series has the following 11 operation modes.

1. Read cycle
2. Early write cycle
3. Delayed write cycle
4. Read-modify-write cycle
5. $\overline{\text{RAS}}$ -only refresh cycle
6. $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh cycle
7. Self refresh cycle (HM51S4265D)
8. EDO page mode read cycle
9. EDO page mode early write cycle
10. EDO page mode delayed write cycle
11. EDO page mode read-modify-write cycle

Inputs

| $\overline{\text{RAS}}$ | $\overline{\text{LCAS}}$ | $\overline{\text{UCAS}}$ | $\overline{\text{WE}}$ | $\overline{\text{OE}}$ | Output | Operation |
|-------------------------|--------------------------|--------------------------|------------------------|------------------------|-----------|--|
| H | H | H | D | D | Open | Standby |
| H | L | L | H | L | Valid | Standby |
| L | L | L | H | L | Valid | Read cycle |
| L | L | L | L* ² | D | Open | Early write cycle |
| L | L | L | L* ² | H | Undefined | Delayed write cycle |
| L | L | L | H to L | L to H | Valid | Read-modify-write cycle |
| L | H | H | D | D | Open | $\overline{\text{RAS}}$ -only refresh cycle |
| H to L | H | L | D | D | Open | $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh cycle |
| | L | H | | | | Self refresh cycle (HM51S4265D) |
| | L | L | | | | |
| L | H to L | H to L | H | L | Valid | EDO page mode read cycle |
| L | H to L | H to L | L* ² | D | Open | EDO page mode early write cycle |
| L | H to L | H to L | L* ² | H | Undefined | EDO page mode delayed write cycle |
| L | H to L | H to L | H to L | L to H | Valid | EDO page mode read-modify-write cycle |
| L | L | L | H | H | Open | Read cycle (Output disabled) |

Notes: 1. H: High(inactive) L: Low(active) D: H or L (H: $V_{IH}(\text{min}) \leq V_{IN} \leq V_{IH}(\text{max})$, L: $V_{IL}(\text{min}) \leq V_{IN} \leq V_{IL}(\text{max})$)

2. $t_{wCS} \geq 0 \text{ ns}$ Early write cycle

$t_{wCS} < 0 \text{ ns}$ Delayed write cycle

3. Mode is determined by the OR function of the $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$. (Mode is set by the earliest of $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ active edge and reset by the latest of $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ inactive edge.) However write OPERATION and output HIZ control are done independently by each $\overline{\text{UCAS}}$, $\overline{\text{LCAS}}$.

ex. if $\overline{\text{RAS}} = \text{H to L}$, $\overline{\text{LCAS}} = \text{L}$, $\overline{\text{UCAS}} = \text{H}$, then $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh cycle is selected.

HM514265D Series, HM51S4265D Series

Absolute Maximum Ratings

| Parameter | Symbol | Value | Unit |
|---|-----------|--------------|------|
| Voltage on any pin relative to V_{SS} | V_T | -1.0 to +7.0 | V |
| Supply voltage relative to V_{SS} | V_{CC} | -1.0 to +7.0 | V |
| Short circuit output current | I_{out} | 50 | mA |
| Power dissipation | P_T | 1.0 | W |
| Operating temperature | T_{opr} | 0 to +70 | °C |
| Storage temperature | T_{stg} | -55 to +125 | °C |

Recommended DC Operating Conditions ($T_a = 0$ to $+70^\circ\text{C}$)

| Parameter | Symbol | Min | Typ | Max | Unit | Notes |
|--------------------|-------------------------------|------|-----|------|------|-------|
| Supply voltage | V_{SS} | 0 | 0 | 0 | V | 2 |
| | V_{CC} (HM51(S)4265D-5/6R) | 4.75 | 5.0 | 5.25 | V | 1, 2 |
| | V_{CC} (HM51(S)4265D-6/7/8) | 4.5 | 5.0 | 5.5 | V | 1, 2 |
| Input high voltage | V_{IH} | 2.4 | — | 6.5 | V | 1 |
| Input low voltage | V_{IL} | -1.0 | — | 0.8 | V | 1 |

Notes: 1. All voltage referred to V_{SS} .

2. The supply voltage with all V_{CC} pins must be on the same level.

The supply voltage with all V_{SS} pins must be on the same level.

DC Characteristics

($T_a = 0$ to 70°C , $V_{CC} = 5\text{ V} \pm 5\%$, $V_{SS} = 0\text{ V}$) (HM51(S)4265D-5/6R) *5

($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$) (HM51(S)4265D-6/7/8) *5

HM514265D, HM51S4265D

| Parameter | Symbol | HM514265D, HM51S4265D | | | | | | | | Unit | Test conditions |
|---|------------|-----------------------|-----|-------|-----|-----|-----|-----|-----|---------------|---|
| | | -5 | | -6/6R | | -7 | | -8 | | | |
| | | Min | Max | Min | Max | Min | Max | Min | Max | | |
| Operating current* ¹ , *2 | I_{CC1} | — | 160 | — | 150 | — | 140 | — | 125 | mA | $\overline{\text{RAS}}$ cycling $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$ cycling $t_{RC} = \text{min}$ |
| Standby current | I_{CC2} | — | 2 | — | 2 | — | 2 | — | 2 | mA | TTL interface $\overline{\text{RAS}}, \overline{\text{UCAS}}, \overline{\text{LCAS}} = V_{IH}$ Dout = High-Z |
| | | — | 1 | — | 1 | — | 1 | — | 1 | mA | CMOS interface $\overline{\text{RAS}}, \overline{\text{UCAS}}, \overline{\text{LCAS}}, \overline{\text{WE}},$ $\overline{\text{OE}} \geq V_{CC} - 0.2\text{ V}$ Dout = High-Z |
| Standby current (L-version) | I_{CC2} | — | 200 | — | 200 | — | 200 | — | 200 | μA | CMOS interface $\overline{\text{RAS}}, \overline{\text{UCAS}}, \overline{\text{LCAS}}, \overline{\text{WE}},$ $\overline{\text{OE}} \geq V_{CC} - 0.2\text{ V}$ Dout = High-Z |
| $\overline{\text{RAS}}$ -only refresh current* ² | I_{CC3} | — | 150 | — | 140 | — | 130 | — | 110 | mA | $t_{RC} = \text{min}$ |
| $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh current* ² | I_{CC6} | — | 150 | — | 140 | — | 130 | — | 110 | mA | $t_{RC} = \text{min}$ |
| EDO page mode current* ¹ , * ³ | I_{CC4} | — | 180 | — | 180 | — | 150 | — | 130 | mA | $t_{HPC} = \text{min}$ |
| Battery backup current* ⁴ (Standby with CBR refresh) (L-version) | I_{CC10} | — | 300 | — | 300 | — | 300 | — | 300 | μA | Standby: CMOS interface Dout = High-Z CBR refresh: $t_{RC} = 250\ \mu\text{s}$ $t_{RAS} \leq 1\ \mu\text{s}$, $\overline{\text{UCAS}}, \overline{\text{LCAS}} = V_{IL}$ $\overline{\text{WE}}, \overline{\text{OE}} = V_{IH}$ |
| Self-refresh mode current (HM51S4265D) | I_{CC11} | — | 1 | — | 1 | — | 1 | — | 1 | mA | CMOS interface, $\overline{\text{RAS}},$ $\overline{\text{UCAS}}, \overline{\text{LCAS}} \leq 0.2\text{ V}$, Dout = High-Z |
| Self-refresh mode current (HM51S4265DL) | I_{CC11} | — | 200 | — | 200 | — | 200 | — | 200 | μA | CMOS interface, $\overline{\text{RAS}},$ $\overline{\text{UCAS}}, \overline{\text{LCAS}} \leq 0.2\text{ V}$, Dout = High-Z |
| Input leakage current | I_{LI} | -10 | 10 | -10 | 10 | -10 | 10 | -10 | 10 | μA | $0\text{ V} \leq V_{in} \leq 7\text{ V}$ |
| Output leakage current | I_{LO} | -10 | 10 | -10 | 10 | -10 | 10 | -10 | 10 | μA | $0\text{ V} \leq V_{out} \leq 7\text{ V}$ Dout = disable |

HM514265D Series, HM51S4265D Series

DC Characteristics

($T_a = 0$ to 70°C , $V_{CC} = 5\text{ V} \pm 5\%$, $V_{SS} = 0\text{ V}$) (HM51(S)4265D-5/6R)*⁵

($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$)(HM51(S)4265D-6/7/8) *⁵ (cont.)

HM514265D, HM51S4265D

| Parameter | Symbol | -5 | | -6/6R | | -7 | | -8 | | Unit | Test conditions |
|---------------------|----------|-----|----------|-------|----------|-----|----------|-----|----------|------|-------------------|
| | | Min | Max | Min | Max | Min | Max | Min | Max | | |
| Output high voltage | V_{OH} | 2.4 | V_{CC} | 2.4 | V_{CC} | 2.4 | V_{CC} | 2.4 | V_{CC} | V | High lout = -2 mA |
| Output low voltage | V_{OL} | 0 | 0.4 | 0 | 0.4 | 0 | 0.4 | 0 | 0.4 | V | Low lout = 2 mA |

Notes: 1. I_{CC} depends on output load condition when the device is selected. I_{CC} max is specified at the output open condition.

2. Address can be changed twice or less while $\overline{RAS} = V_{IL}$.

3. Address can be changed once or less within one EDO page cycle.

4. $V_{IH} \geq V_{CC} - 0.2\text{ V}$, $0 \leq V_{IL} \leq 0.2\text{ V}$, Address can be changed once or less while $\overline{RAS} = V_{IL}$.

5. All the V_{CC} pins should be supplied with the same voltage. And all the V_{SS} pins should be supplied with the same voltage.

Capacitance ($T_a = +25^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 5\%$) (HM51(S)4265D-5/6R)

($T_a = +25^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 10\%$) (HM51(S)4265D-6/7/8)

| Parameter | Symbol | Typ | Max | Unit | Notes |
|--|-----------|-----|-----|------|-------|
| Input capacitance (Address) | C_{I1} | — | 5 | pF | 1 |
| Input capacitance (Clocks) | C_{I2} | — | 7 | pF | 1 |
| Output capacitance (Data-in, Data-out) | $C_{I/O}$ | — | 10 | pF | 1, 2 |

Notes: 1. Capacitance measured with Boonton Meter or effective capacitance measuring method.

2. \overline{RAS} , \overline{UCAS} and $\overline{LCAS} = V_{IH}$ to disable Dout.

AC Characteristics ($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 5\%$, $V_{SS} = 0\text{ V}$)

(HM51(S)4265D-5/6R)*^{1, *14, *15, *17, *18}

($T_a = 0$ to $+70^\circ\text{C}$, $V_{CC} = 5\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$)

(HM51(S)4265D-6/7/8)*^{1, *14, *15, *17, *18}

Test Conditions

- Input rise and fall time : 2 ns
- Input levels: $V_{IL} = 0\text{ V}$, $V_{IH} = 3.0\text{ V}$
- Input timing reference levels : 0.8 V, 2.4 V
- Output timing reference levels : 0.8 V, 2.0 V
- Output load : 1 TTL gate + C_L (50 pF) (Including scope and jig)

HM514265D Series, HM51S4265D Series

Read, Write, Read-Modify-Write and Refresh Cycles (Common parameters)

| | | HM514265D, HM51S4265D | | | | | | | | | |
|---|-----------|-----------------------|-------|--------|-------|-----|-------|-----|-------|------|-------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| Random read or write cycle time | t_{RC} | 84 | — | 104 | — | 124 | — | 144 | — | ns | |
| \overline{RAS} precharge time | t_{RP} | 30 | — | 40 | — | 50 | — | 60 | — | ns | |
| \overline{RAS} pulse width | t_{RAS} | 50 | 10000 | 60 | 10000 | 70 | 10000 | 80 | 10000 | ns | 27 |
| \overline{CAS} pulse width | t_{CAS} | 8 | 10000 | 10 | 10000 | 13 | 10000 | 15 | 10000 | ns | 28 |
| Row address setup time | t_{ASR} | 0 | — | 0 | — | 0 | — | 0 | — | ns | |
| Row address hold time | t_{RAH} | 8 | — | 10 | — | 10 | — | 10 | — | ns | |
| Column address setup time | t_{ASC} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 19 |
| Column address hold time | t_{CAH} | 8 | — | 10 | — | 13 | — | 15 | — | ns | 19 |
| \overline{RAS} to \overline{CAS} delay time | t_{RCD} | 18 | 35 | 20 | 45 | 20 | 50 | 20 | 60 | ns | 8 |
| \overline{RAS} to column address delay time | t_{RAD} | 10 | 25 | 15 | 30 | 15 | 35 | 15 | 40 | ns | 9 |
| \overline{RAS} hold time | t_{RSH} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |
| \overline{CAS} hold time | t_{CSH} | 40 | — | 48 | — | 58 | — | 68 | — | ns | 29 |
| \overline{CAS} to \overline{RAS} precharge time | t_{CRP} | 10 | — | 10 | — | 10 | — | 10 | — | ns | 20 |
| \overline{OE} to Din delay time | t_{ODD} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |
| \overline{OE} delay time from Din | t_{DZO} | 0 | — | 0 | — | 0 | — | 0 | — | ns | |
| \overline{CAS} setup time from Din | t_{DZC} | 0 | — | 0 | — | 0 | — | 0 | — | ns | |
| Transition time (rise and fall) | t_T | 2 | 50 | 2 | 50 | 2 | 50 | 2 | 50 | ns | 7 |
| Refresh period | t_{REF} | — | 8 | — | 8 | — | 8 | — | 8 | ms | |
| Refresh period (L-version) | t_{REF} | — | 128 | — | 128 | — | 128 | — | 128 | ms | |

HM514265D Series, HM51S4265D Series

Read Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|---|-------------------|-----------------------|-----|--------|-----|-----|-----|-----|-----|------|----------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| Access time from $\overline{\text{RAS}}$ | t_{RAC} | — | 50 | — | 60 | — | 70 | — | 80 | ns | 2, 3 |
| Access time from $\overline{\text{CAS}}$ | t_{CAC} | — | 15 | — | 15 | — | 20 | — | 20 | ns | 3, 4, 13 |
| Access time from address | t_{AA} | — | 25 | — | 30 | — | 35 | — | 40 | ns | 3, 5, 13 |
| Access time from $\overline{\text{OE}}$ | t_{OAC} | — | 15 | — | 15 | — | 20 | — | 20 | ns | 3, 23 |
| Read command setup time | t_{RCS} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 19 |
| Read command hold time to $\overline{\text{CAS}}$ | t_{RCH} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 16, 20 |
| Read command hold time to $\overline{\text{RAS}}$ | t_{RRH} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 16 |
| Column address to $\overline{\text{RAS}}$ lead time | t_{RAL} | 25 | — | 30 | — | 35 | — | 40 | — | ns | |
| Column address to $\overline{\text{CAS}}$ lead time | t_{CAL} | 13 | — | 18 | — | 23 | — | 28 | — | ns | |
| Output buffer turn-off time | t_{OFF1} | — | 13 | — | 15 | — | 15 | — | 15 | ns | 6, 25 |
| Output buffer turn-off time to $\overline{\text{OE}}$ | t_{OFF2} | — | 13 | — | 15 | — | 15 | — | 15 | ns | 6 |
| $\overline{\text{CAS}}$ to Din delay time | t_{CDD} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |
| $\overline{\text{RAS}}$ to Din delay time | t_{RDD} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |
| $\overline{\text{WE}}$ to Din delay time | t_{WDD} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |
| $\overline{\text{OE}}$ pulse width | t_{OEP} | 13 | — | 15 | — | 20 | — | 20 | — | ns | 23 |
| Turn-off to $\overline{\text{RAS}}$ | t_{OFR} | — | 13 | — | 15 | — | 15 | — | 15 | ns | 6, 25 |
| Turn-off to $\overline{\text{WE}}$ | t_{WEZ} | — | 13 | — | 15 | — | 15 | — | 15 | ns | 6 |
| Output data hold time | t_{OH} | 5 | — | 5 | — | 5 | — | 5 | — | ns | |
| Output data hold time from $\overline{\text{RAS}}$ | t_{OHR} | 5 | — | 5 | — | 5 | — | 5 | — | ns | |
| Read command hold time from $\overline{\text{RAS}}$ | t_{RCHR} | 50 | — | 60 | — | 70 | — | 80 | — | ns | |
| Read command hold time from $\overline{\text{CAS}}$ | t_{RCHC} | 15 | — | 15 | — | 18 | — | 20 | — | ns | |
| Read command hold time from column address | t_{RCHA} | 25 | — | 30 | — | 35 | — | 40 | — | ns | |

Write Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|---|-----------|-----------------------|-----|--------|-----|-----|-----|-----|-----|------|--------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| Write command setup time | t_{WCS} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 10, 19 |
| Write command hold time | t_{WCH} | 8 | — | 10 | — | 13 | — | 15 | — | ns | 19 |
| Write command pulse width | t_{WP} | 8 | — | 10 | — | 10 | — | 10 | — | ns | |
| Write command to \overline{RAS} lead time | t_{RWL} | 8 | — | 10 | — | 13 | — | 15 | — | ns | |
| Write command to \overline{CAS} lead time | t_{CWL} | 8 | — | 10 | — | 13 | — | 15 | — | ns | 21 |
| Data-in setup time | t_{DS} | 0 | — | 0 | — | 0 | — | 0 | — | ns | 11, 21 |
| Data-in hold time | t_{DH} | 8 | — | 10 | — | 13 | — | 15 | — | ns | 11, 21 |

Read-Modify-Write Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|--|-----------|-----------------------|-----|--------|-----|-----|-----|-----|-----|------|-------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| Read-modify-write cycle time | t_{RWC} | 109 | — | 133 | — | 159 | — | 183 | — | ns | |
| \overline{RAS} to \overline{WE} delay time | t_{RWD} | 65 | — | 77 | — | 90 | — | 102 | — | ns | 10 |
| \overline{CAS} to \overline{WE} delay time | t_{CWD} | 30 | — | 32 | — | 38 | — | 42 | — | ns | 10 |
| Column address to \overline{WE} delay time | t_{AWD} | 42 | — | 47 | — | 55 | — | 62 | — | ns | 10 |
| \overline{OE} hold time from \overline{WE} | t_{OEH} | 13 | — | 15 | — | 18 | — | 20 | — | ns | |

HM514265D Series, HM51S4265D Series

Refresh Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|---|------------------|-----------------------|-----|--------|-----|-----|-----|-----|-----|------|-------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| $\overline{\text{CAS}}$ setup time (CBR refresh cycle) | t_{CSR} | 10 | — | 10 | — | 10 | — | 10 | — | ns | 19 |
| $\overline{\text{CAS}}$ hold time (CBR refresh cycle) | t_{CHR} | 10 | — | 10 | — | 10 | — | 10 | — | ns | 20 |
| $\overline{\text{RAS}}$ precharge to $\overline{\text{CAS}}$ hold time | t_{RPC} | 10 | — | 10 | — | 10 | — | 10 | — | ns | 19 |
| $\overline{\text{CAS}}$ precharge time in normal mode | t_{CPN} | 8 | — | 10 | — | 13 | — | 15 | — | ns | 22 |

EDO Page Mode Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|---|-------------------|-----------------------|--------|--------|--------|-----|--------|-----|--------|------|--------------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| EDO page mode cycle time | t_{HPC} | 20 | — | 25 | — | 30 | — | 35 | — | ns | 24 |
| EDO page mode $\overline{\text{CAS}}$ precharge time | t_{CP} | 8 | — | 10 | — | 13 | — | 15 | — | ns | |
| EDO page mode $\overline{\text{RAS}}$ pulse width | t_{RASC} | — | 100000 | — | 100000 | — | 100000 | — | 100000 | ns | 12 |
| Access time from $\overline{\text{CAS}}$ precharge | t_{ACP} | — | 28 | — | 35 | — | 40 | — | 45 | ns | 3, 13, 17 |
| $\overline{\text{RAS}}$ hold time from $\overline{\text{CAS}}$ precharge | t_{RHCP} | 30 | — | 35 | — | 40 | — | 45 | — | ns | |
| Output data hold time from $\overline{\text{CAS}}$ low | t_{DOH} | 5 | — | 5 | — | 5 | — | 5 | — | ns | 26 |
| $\overline{\text{CAS}}$ hold time referred $\overline{\text{OE}}$ | t_{COL} | 8 | — | 10 | — | 13 | — | 20 | — | ns | |
| $\overline{\text{CAS}}$ to $\overline{\text{OE}}$ setup time | t_{COP} | 5 | — | 5 | — | 5 | — | 5 | — | ns | |
| Read command hold time from $\overline{\text{CAS}}$ precharge | t_{RCHP} | 30 | — | 35 | — | 40 | — | 45 | — | ns | |

EDO Page Mode Read-Modify-Write Cycle

| | | HM514265D, HM51S4265D | | | | | | | | | |
|--|-------------------|-----------------------|-----|--------|-----|-----|-----|-----|-----|------|-------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| EDO page mode read-modify-write cycle time | t_{HPCM} | 57 | — | 66 | — | 77 | — | 86 | — | ns | |
| EDO page mode read-modify-write cycle CAS precharge to $\overline{\text{WE}}$ delay time | t_{CPW} | 45 | — | 52 | — | 60 | — | 67 | — | ns | 10 |

Self Refresh Mode

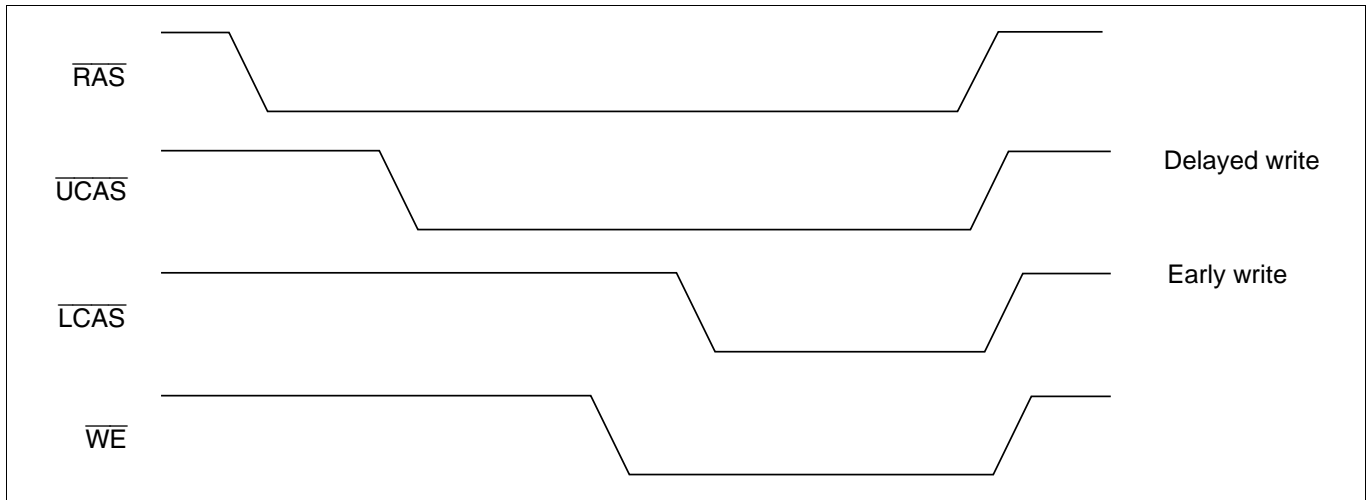
| | | HM51S4265D | | | | | | | | | |
|---|-------------------|------------|-----|--------|-----|-----|-----|-----|-----|------|------------|
| | | -5 | | -6/-6R | | -7 | | -8 | | | |
| Parameter | Symbol | Min | Max | Min | Max | Min | Max | Min | Max | Unit | Notes |
| $\overline{\text{RAS}}$ pulse width (self refresh) | t_{RASS} | 100 | — | 100 | — | 100 | — | 100 | — | ns | 30, 31, 32 |
| $\overline{\text{RAS}}$ precharge time (self refresh) | t_{RPS} | 90 | — | 110 | — | 130 | — | 150 | — | ns | |
| $\overline{\text{CAS}}$ hold time (self refresh) | t_{CHS} | -50 | — | -50 | — | -50 | — | -50 | — | ns | 21 |

- Notes:
- AC measurements assume $t_T = 2 \text{ ns}$, $V_{\text{IH}} = 3.0 \text{ V}$, $V_{\text{IL}} = 0.0 \text{ V}$
 - Assumes that $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{max})$ and $t_{\text{RAD}} \leq t_{\text{RAD}}(\text{max})$. If t_{RCD} or t_{RAD} is greater than the maximum recommended value shown in this table, t_{RAC} exceeds the value shown.
 - Measured with a load circuit equivalent to 1 TTL loads and 50 pF.
 - Assumes that $t_{\text{RCD}} \geq t_{\text{RCD}}(\text{max})$ and $t_{\text{RAD}} \leq t_{\text{RAD}}(\text{max})$.
 - Assumes that $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{max})$ and $t_{\text{RAD}} \geq t_{\text{RAD}}(\text{max})$.
 - $t_{\text{OFF1}}(\text{max})$, $t_{\text{OFF2}}(\text{max})$, $t_{\text{OFR}}(\text{max})$ and $t_{\text{WEZ}}(\text{max})$ define the time at which the output achieves the open circuit condition and is not referred to output voltage levels.
 - $V_{\text{IH}}(\text{min})$ and $V_{\text{IL}}(\text{max})$ are reference levels for measuring timing of input signals. Also, transition times are measured between V_{IH} and V_{IL} .
 - Operation with the $t_{\text{RCD}}(\text{max})$ limit insures that $t_{\text{RAC}}(\text{max})$ can be met, $t_{\text{RCD}}(\text{max})$ is specified as a reference point only, if t_{RCD} is greater than the specified $t_{\text{RCD}}(\text{max})$ limit, then access time is controlled exclusively by t_{CAC} .
 - Operation with the $t_{\text{RAD}}(\text{max})$ limit insures that $t_{\text{RAC}}(\text{max})$ can be met, $t_{\text{RAD}}(\text{max})$ is specified as a reference point only, if t_{RAD} is greater than the specified $t_{\text{RAD}}(\text{max})$ limit, then access time is controlled exclusively by t_{AA} .
 - t_{WCS} , t_{RWD} , t_{CWD} and t_{AWD} are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only: if $t_{\text{WCS}} \geq t_{\text{WCS}}(\text{min})$, the cycle is an early write cycle and the data out pin will remain open circuit (high impedance) throughout the entire cycle; if $t_{\text{RWD}} \geq t_{\text{RWD}}(\text{min})$, $t_{\text{CWD}} \geq t_{\text{CWD}}(\text{min})$, $t_{\text{AWD}} \geq t_{\text{AWD}}(\text{min})$ and $t_{\text{CPW}} \geq t_{\text{CPW}}(\text{min})$, the cycle is a read-modify-write and the data output will contain data read from the selected cell; if neither of the above sets of conditions is satisfied, the condition of the data out (at access time) is indeterminate.

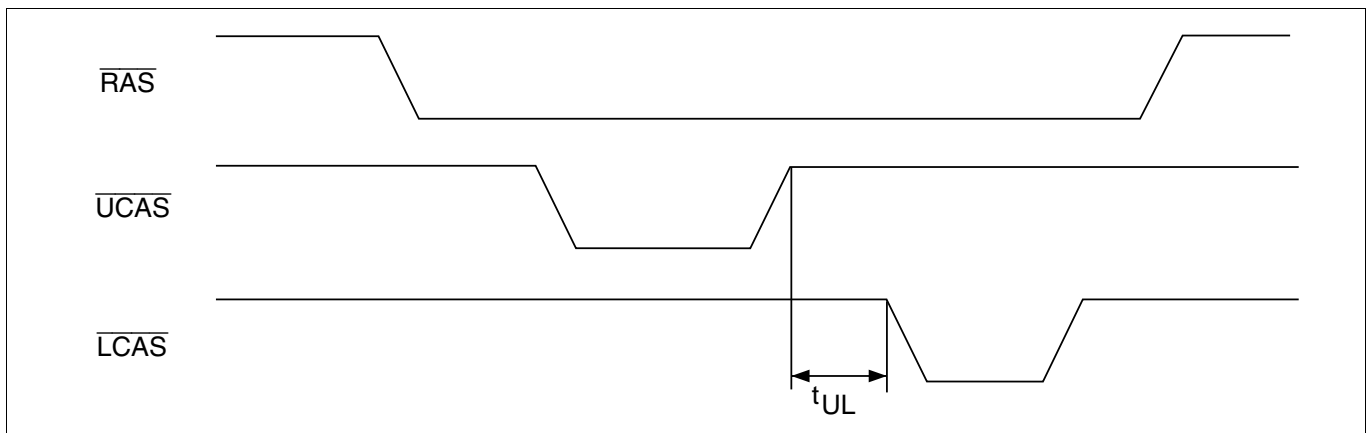
11. These parameters are referred to $\overline{\text{CAS}}$ leading edge in an early write cycle and to $\overline{\text{WE}}$ leading edge in a delayed write or a read-modify-write cycle.
12. t_{RASC} defines $\overline{\text{RAS}}$ pulse width in EDO page mode cycles.
13. Access time is determined by the longest among t_{AA} , t_{CAC} and t_{ACP} .
14. An initial pause of 100 μs is required after power up followed by a minimum of eight initialization cycles ($\overline{\text{RAS}}$ -only refresh cycle or $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh cycle). If the internal refresh counter is used, a minimum of eight $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ refresh cycles is required.
15. In delayed write or read-modify-write cycles, $\overline{\text{OE}}$ must disable output buffer prior to applying data to the device.
16. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
17. When both $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ go low at the same time, all 16-bit data are written into the device. $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ cannot be staggered within the same write/read cycles.
18. All the V_{CC} and V_{SS} pins shall be supplied with the same voltages.
19. t_{ASC} , t_{CAH} , t_{RCS} , t_{WCS} , t_{WCH} , t_{CSR} and t_{RPC} are determined by the earlier falling edge of $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$.
20. t_{CRP} , t_{CHR} , t_{ACP} , t_{RCH} and t_{CPW} are determined by the later rising edge of $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$.
21. t_{CWL} , t_{DH} , t_{DS} and t_{CHS} should be satisfied by both $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$.
22. t_{CPN} and t_{CP} are determined by the time that both $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ are high.
23. When output buffers are enabled once, sustain the low impedance state until valid data is obtained. When output buffer is turned on and off within a very short time, generally it causes large $V_{\text{CC}}/V_{\text{SS}}$ line noise, which causes to degrade $V_{\text{IH min}}/V_{\text{IL max}}$ level.
24. t_{HPC} (min) can be achieved during a series of EDO page mode early write cycles or EDO page mode read cycles. If both write and read operation are mixed in a EDO page mode $\overline{\text{RAS}}$ cycle (EDO page mode mix cycle (1), (2)), minimum value of $\overline{\text{CAS}}$ cycle t_{HPC} ($t_{\text{CAS}} + t_{\text{CP}} + 2t_{\text{T}}$) becomes greater than the specified t_{HPC} (min) value.
25. t_{OFF1} and t_{OFFR} are determined by the later rising edge of $\overline{\text{RAS}}$ or $\overline{\text{CAS}}$.
26. t_{DOH} defines the time at which the output level satisfies the output timing reference levels. Measured with the test conditions.
27. t_{RAS} (min) = t_{RWD} (min) + t_{RWL} (min) + t_{T} in read-modify-write cycle.
28. t_{CAS} (min) = t_{CWD} (min) + t_{CWL} (min) + t_{T} in read-modify-write cycle.
29. t_{CSH} (min) can be achieved when $t_{\text{RCD}} \leq t_{\text{CSH}}$ (min) - t_{CAS} (min).
30. Please do not use t_{RASS} timing, 10 $\mu\text{s} \leq t_{\text{RASS}} \leq 100 \mu\text{s}$. During this period, the device is in transition state from normal operation mode to self refresh mode. If $t_{\text{RASS}} > 100 \mu\text{s}$, then $\overline{\text{RAS}}$ precharge time should use t_{RPS} instead of t_{RP} .
31. If you use distributed CBR refresh mode with 15.6 μs interval in normal read/write cycle, CBR refresh should be executed within 15.6 μs immediately after exiting from and before entering into self refresh mode.
32. If you use $\overline{\text{RAS}}$ only refresh or CBR burst refresh mode in normal read/write cycle, 512 cycles of distributed CBR refresh with 15.6 μs interval should be executed within 8 ms immediately after exiting from and before entering into the self refresh mode.
33. Repetitive self refresh mode without refreshing all memory is not allowed. Once you exit from self refresh mode, all memory cells need to be refreshed before re-entering the self refresh mode again.
34. XXX: H or L (H: V_{IH} (min) $\leq V_{\text{IN}} \leq V_{\text{IH}}$ (max), L: V_{IL} (min) $\leq V_{\text{IN}} \leq V_{\text{IL}}$ (max))
/////: Invalid Dout
When the address, clock and input pins are not described on timing waveforms, their pins must be applied V_{IH} or V_{IL} .

Notes concerning $\overline{2CAS}$ control

1. Each of the $\overline{UCAS/LCAS}$ should satisfy the timing specifications individually.
2. Different operation mode for upper/lower byte is not allowed; such as following.



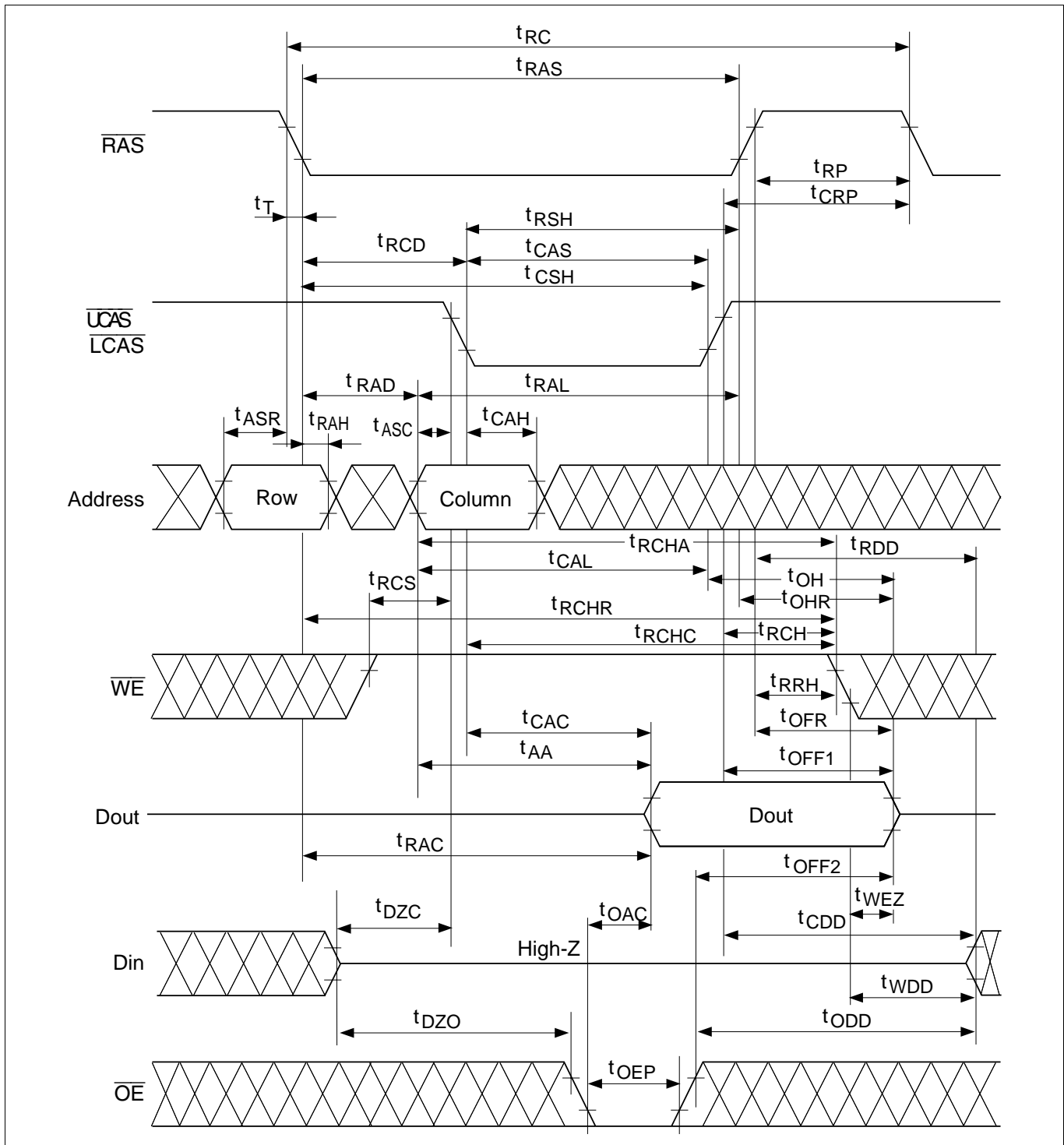
3. Closely separated upper/lower byte control is not allowed. However when the condition ($t_{CP} \leq t_{UL}$) is satisfied, fast page mode can be performed.



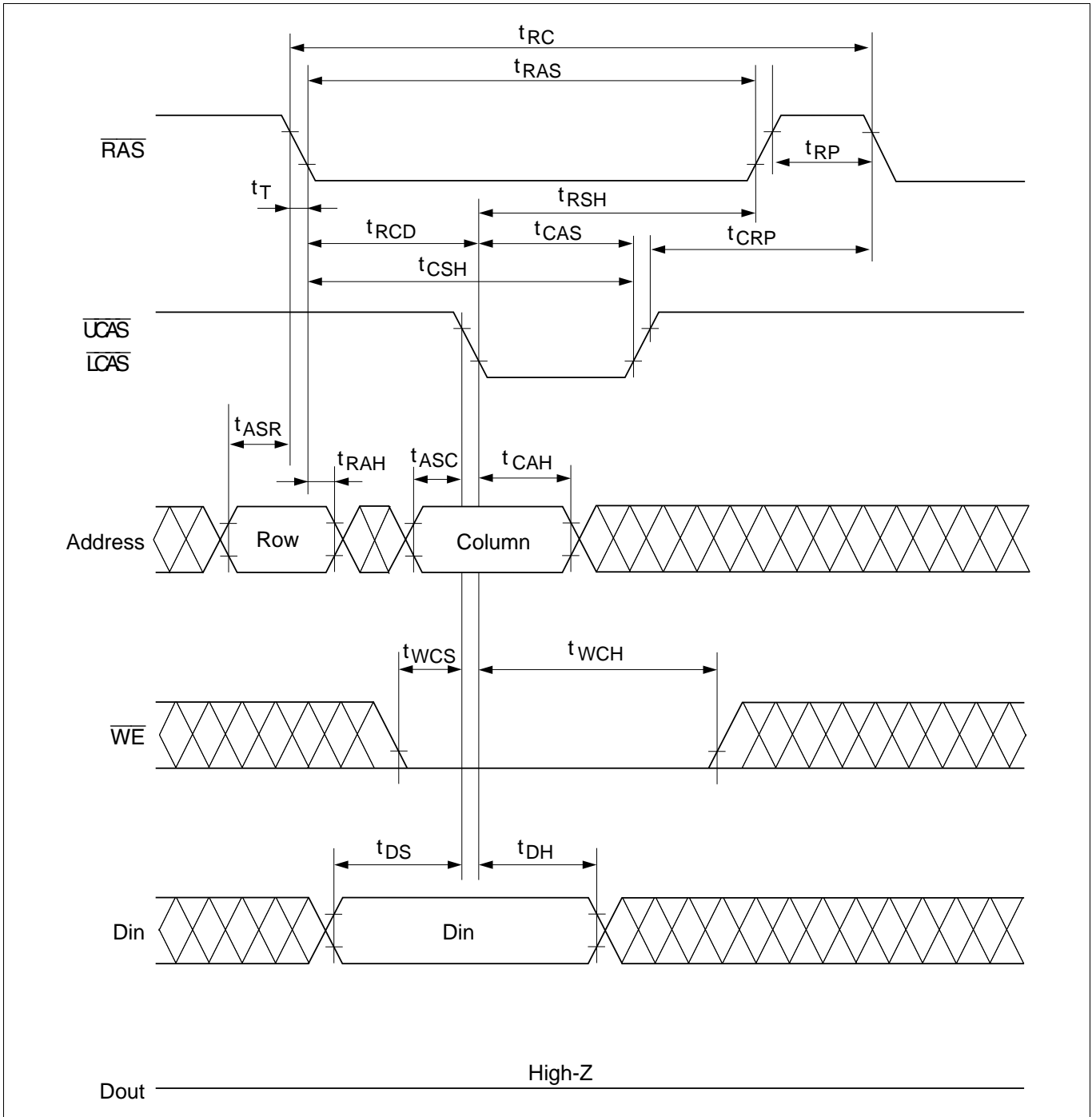
4. Byte control operation by remaining \overline{UCAS} or \overline{LCAS} high is guaranteed.

Timing Waveforms*34

Read Cycle

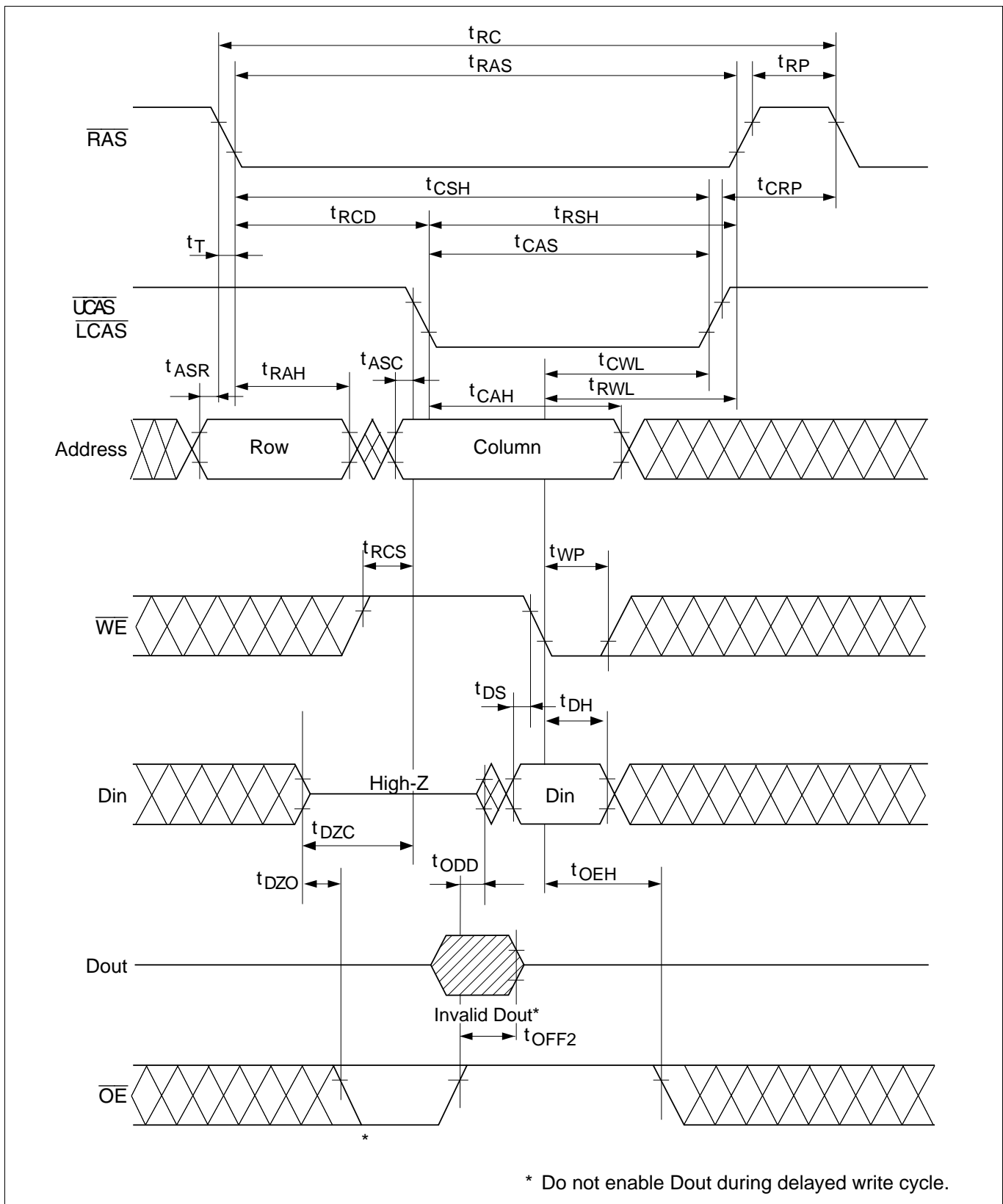


Early Write Cycle

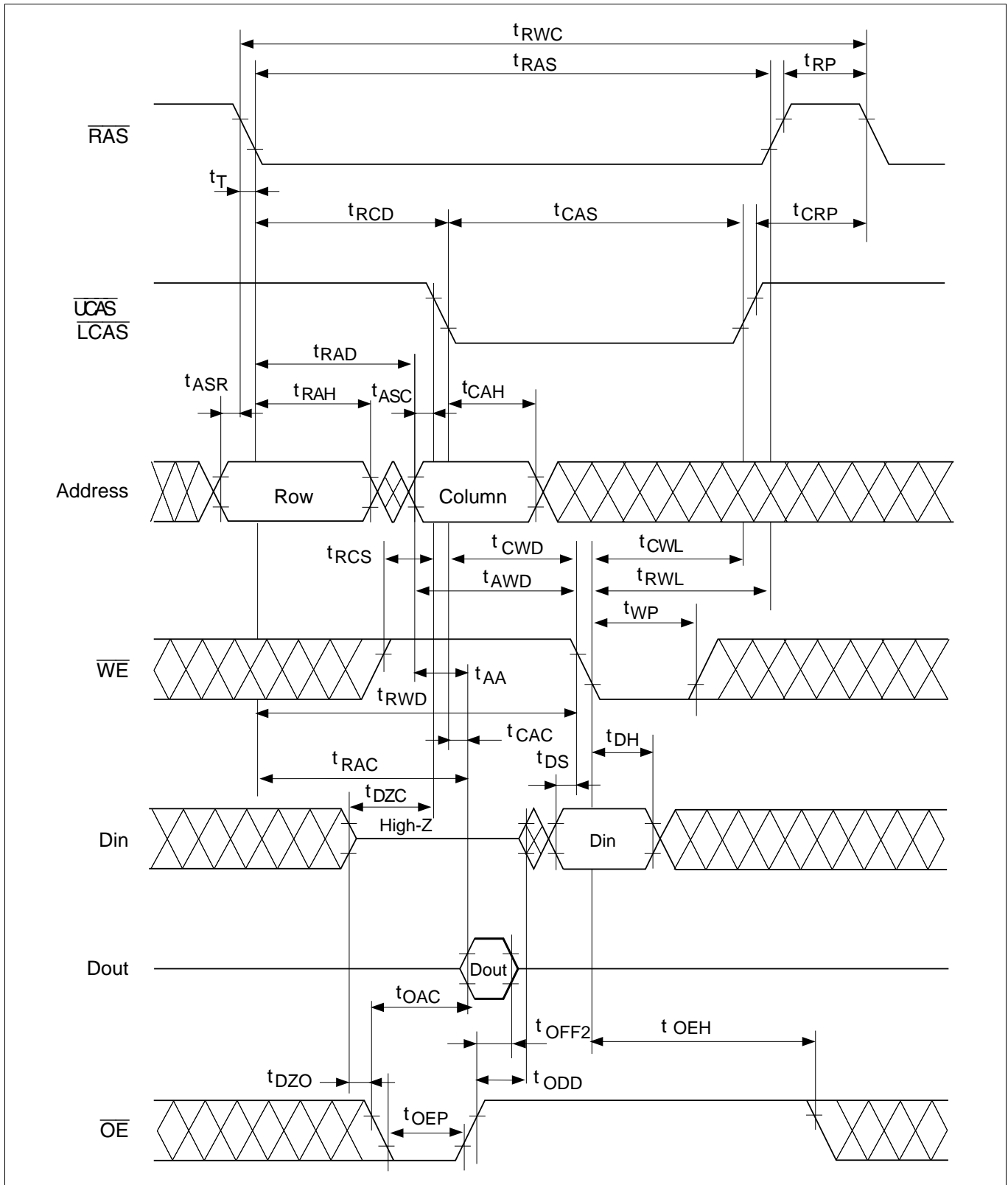


HM514265D Series, HM51S4265D Series

Delayed Write Cycle

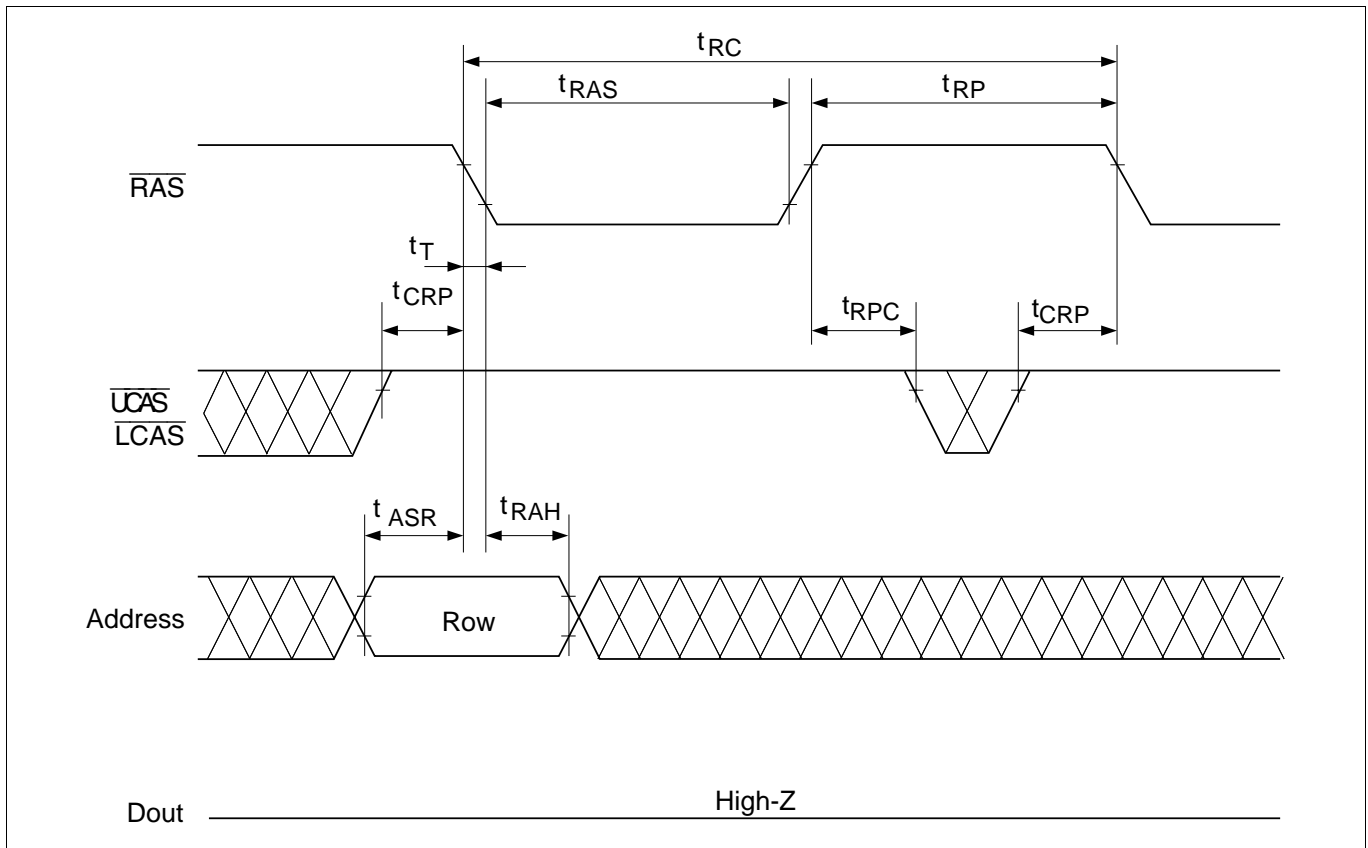


Read-Modify-Write Cycle

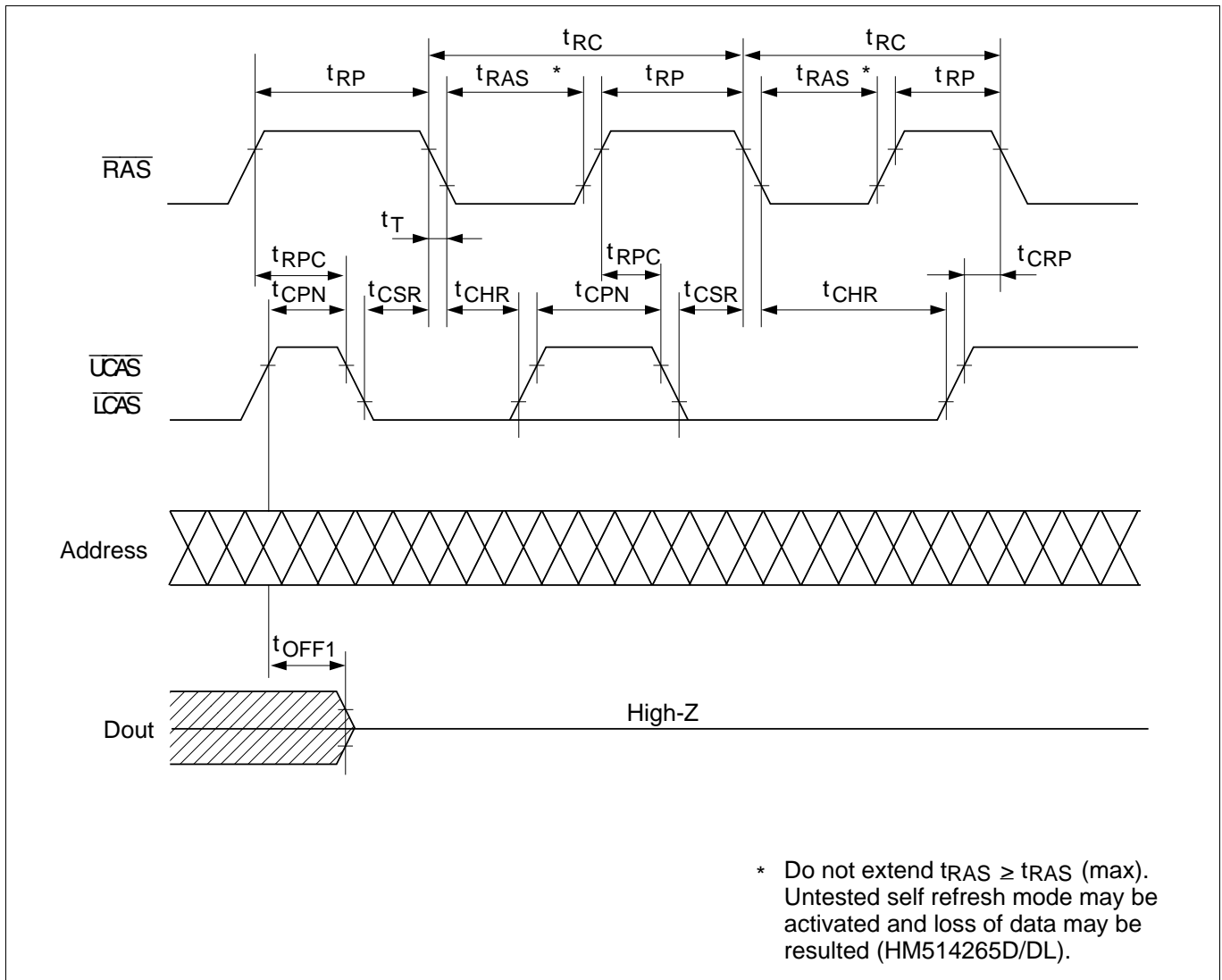


HM514265D Series, HM51S4265D Series

$\overline{\text{RAS}}$ -Only Refresh Cycle

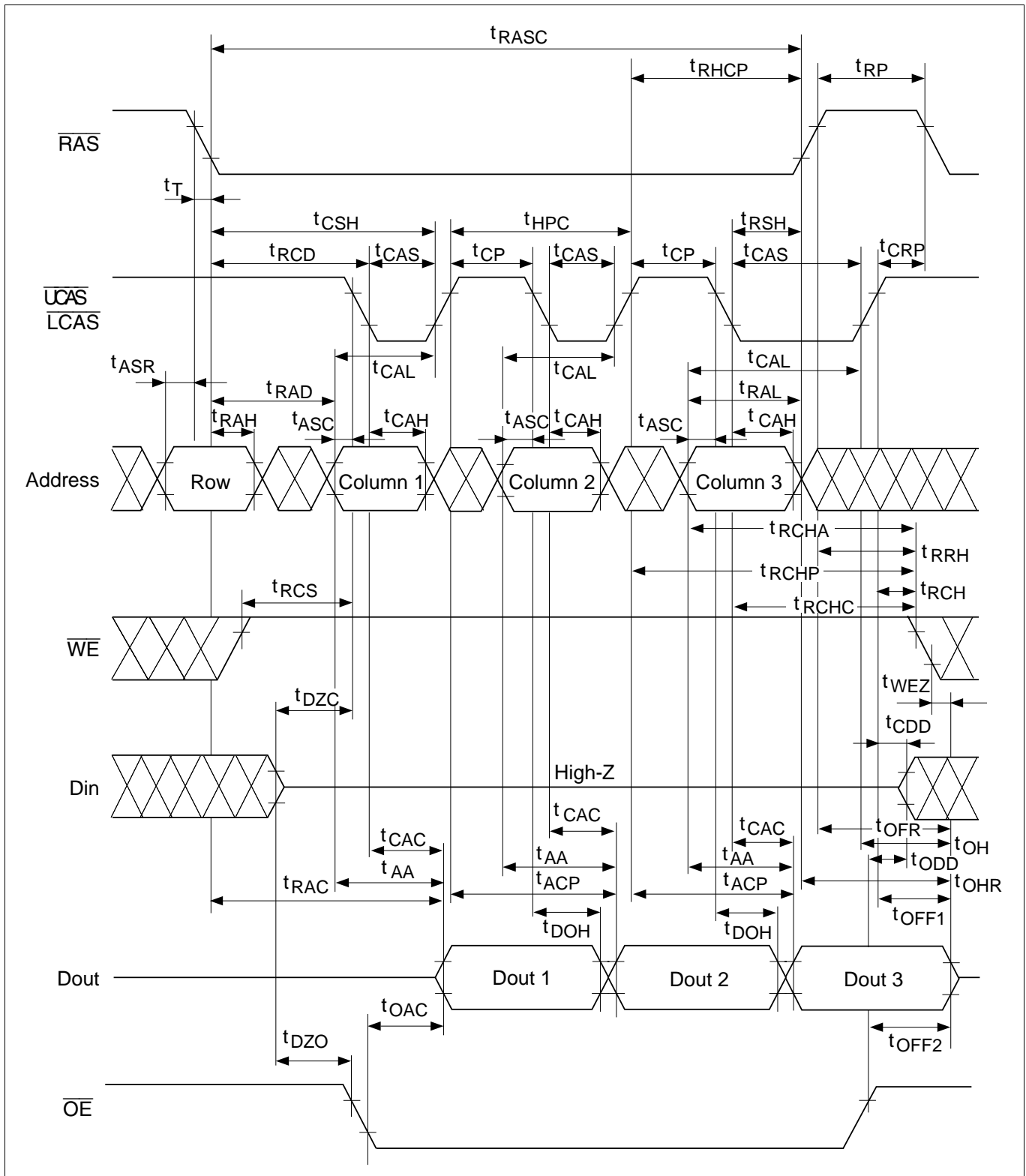


CAS-Before-RAS Refresh Cycle

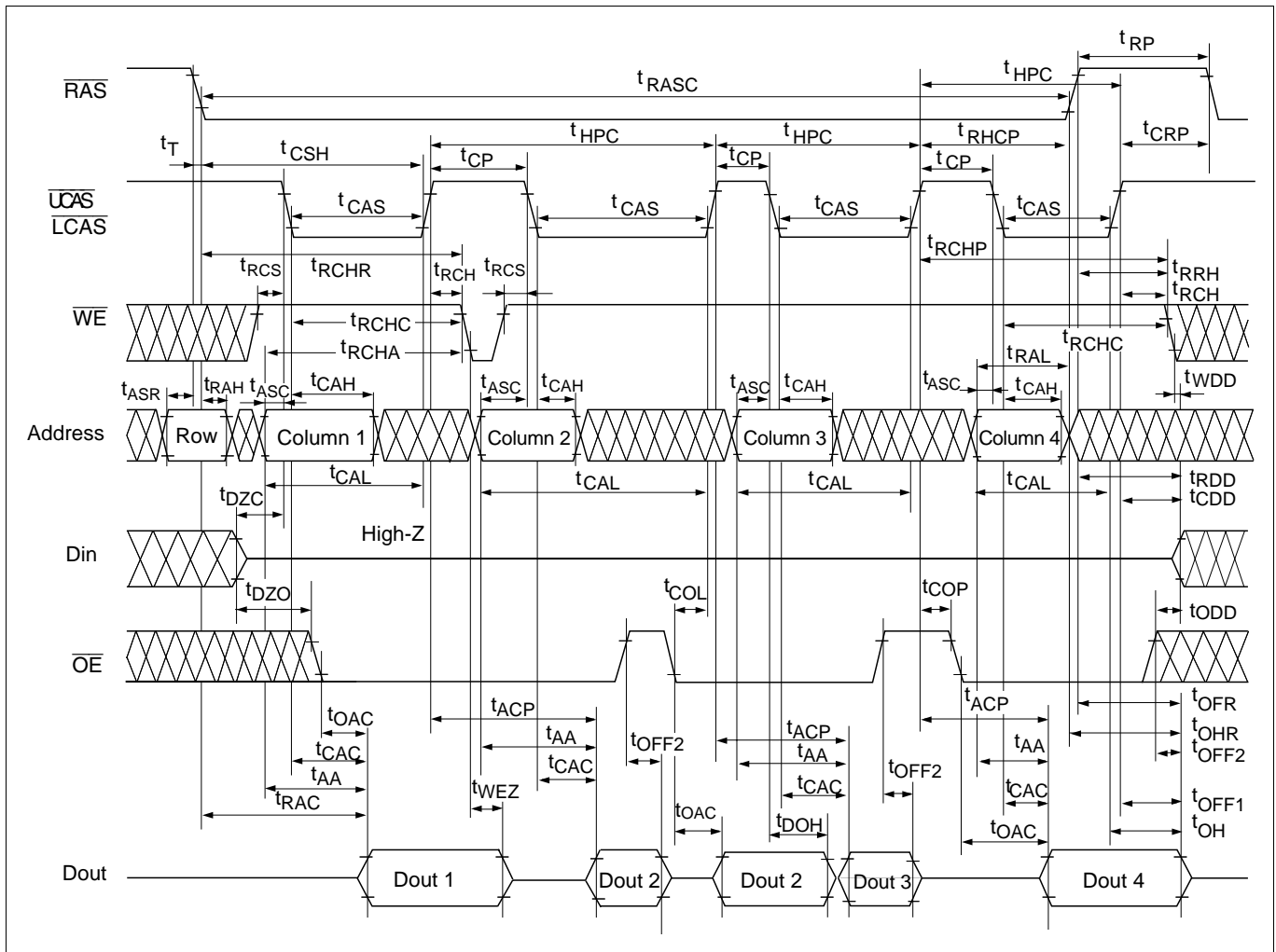


HM514265D Series, HM51S4265D Series

EDO Page Mode Read Cycle (t_{HPC} minimum cycle operation)

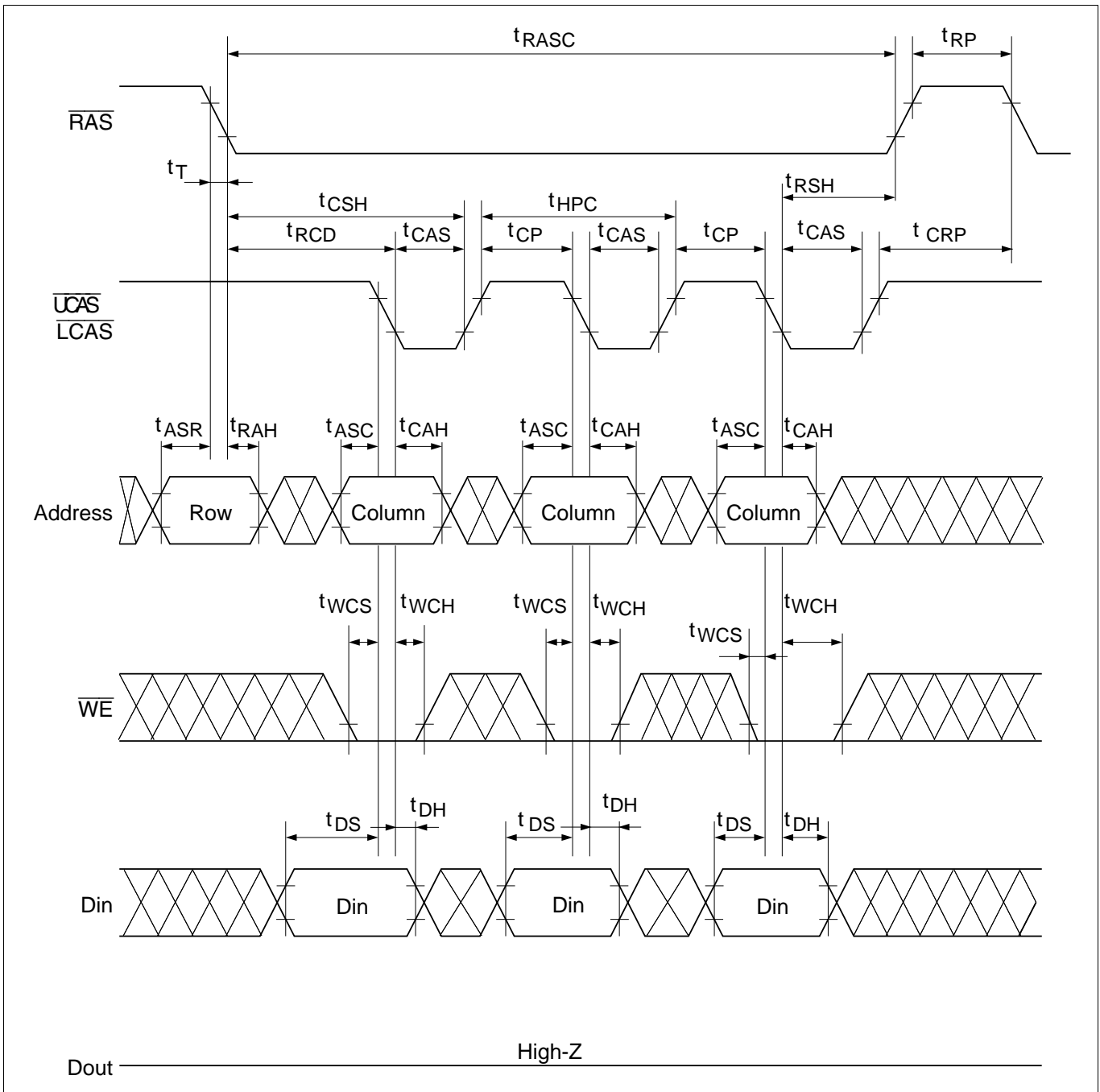


EDO Page Mode Read Cycle (High-Z control by \overline{WE} and \overline{OE})

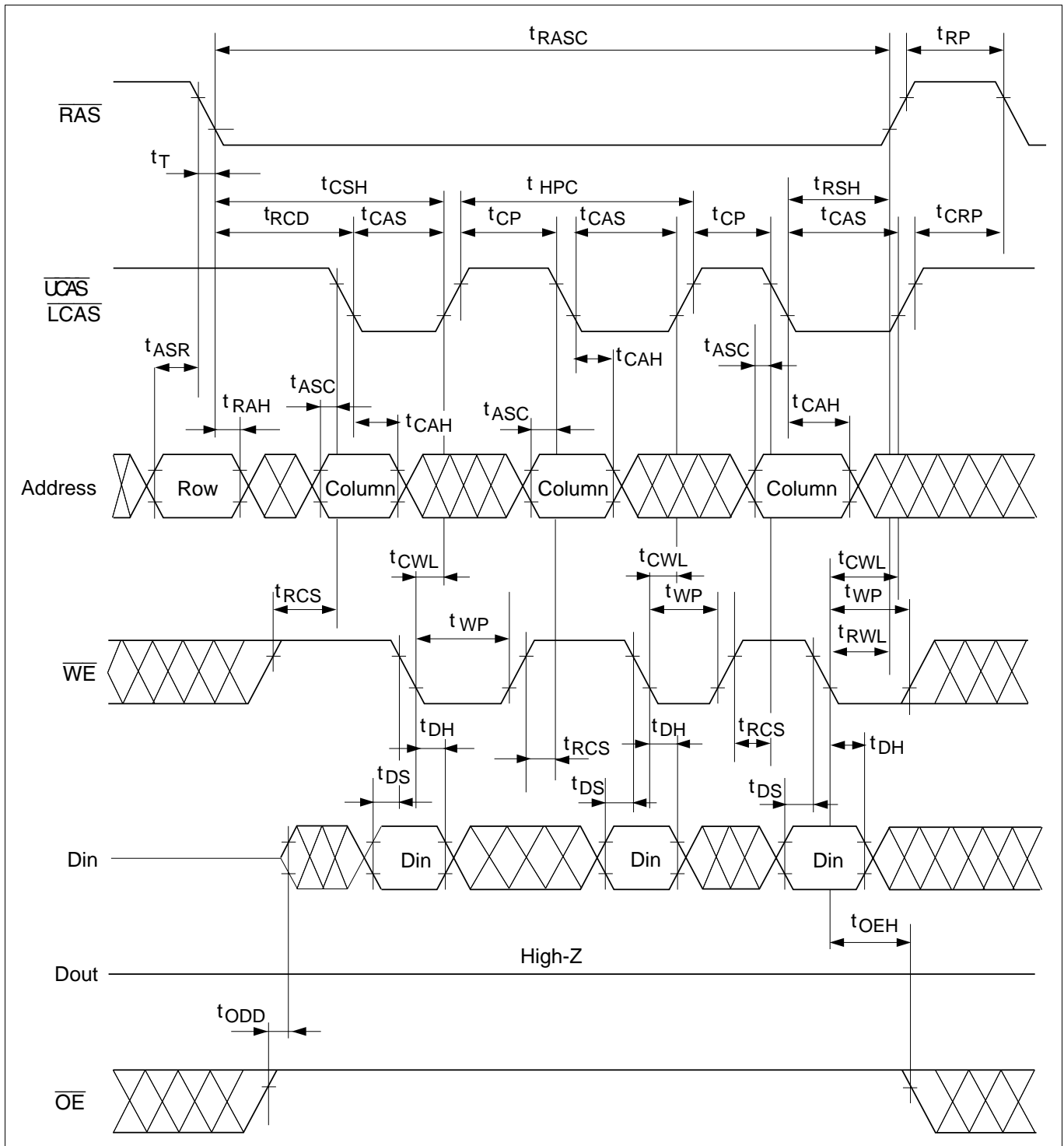


HM514265D Series, HM51S4265D Series

EDO Page Mode Early Write Cycle (t_{HPC} minimum cycle operation)

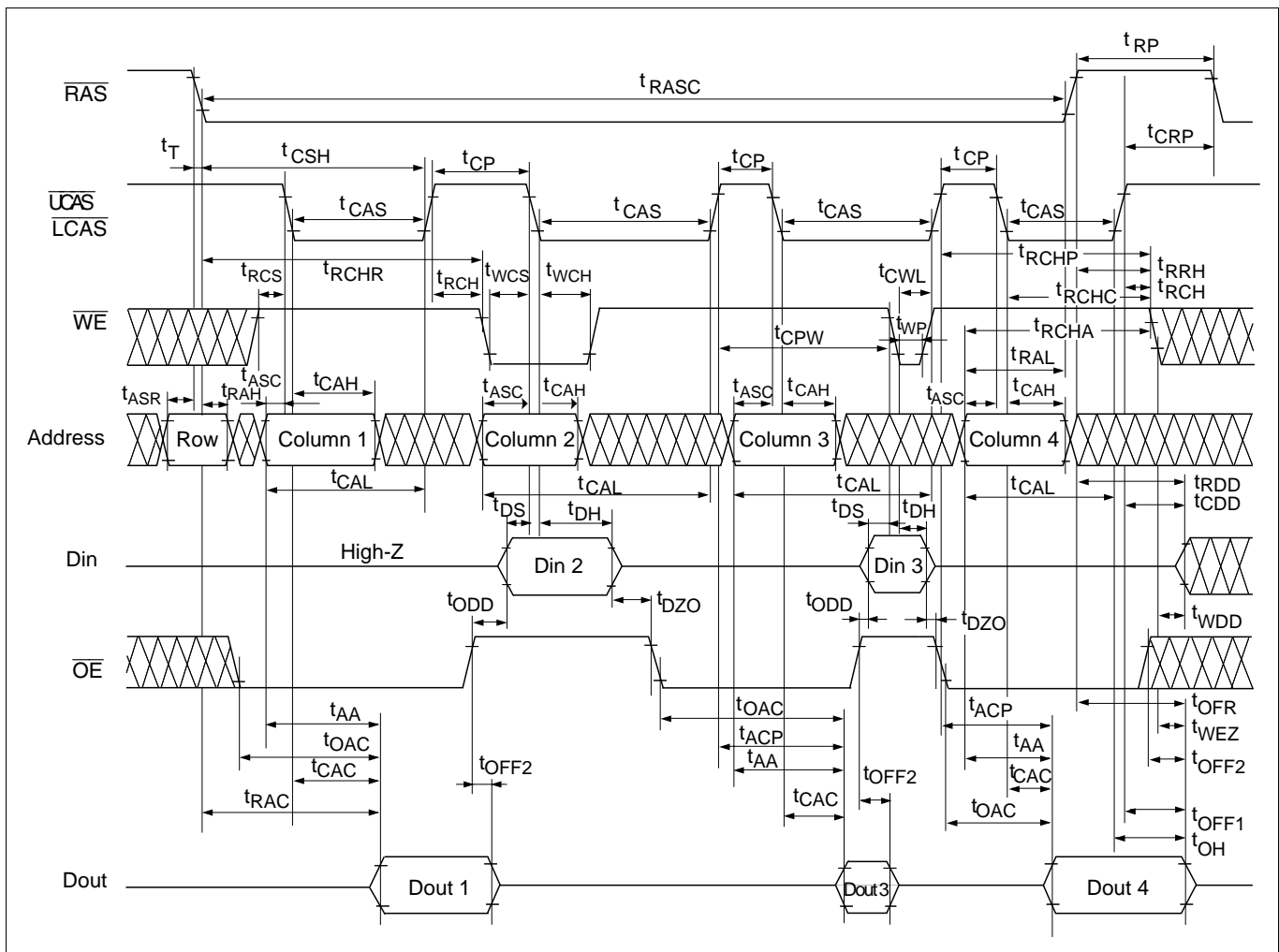


EDO Page Mode Delayed Write Cycle

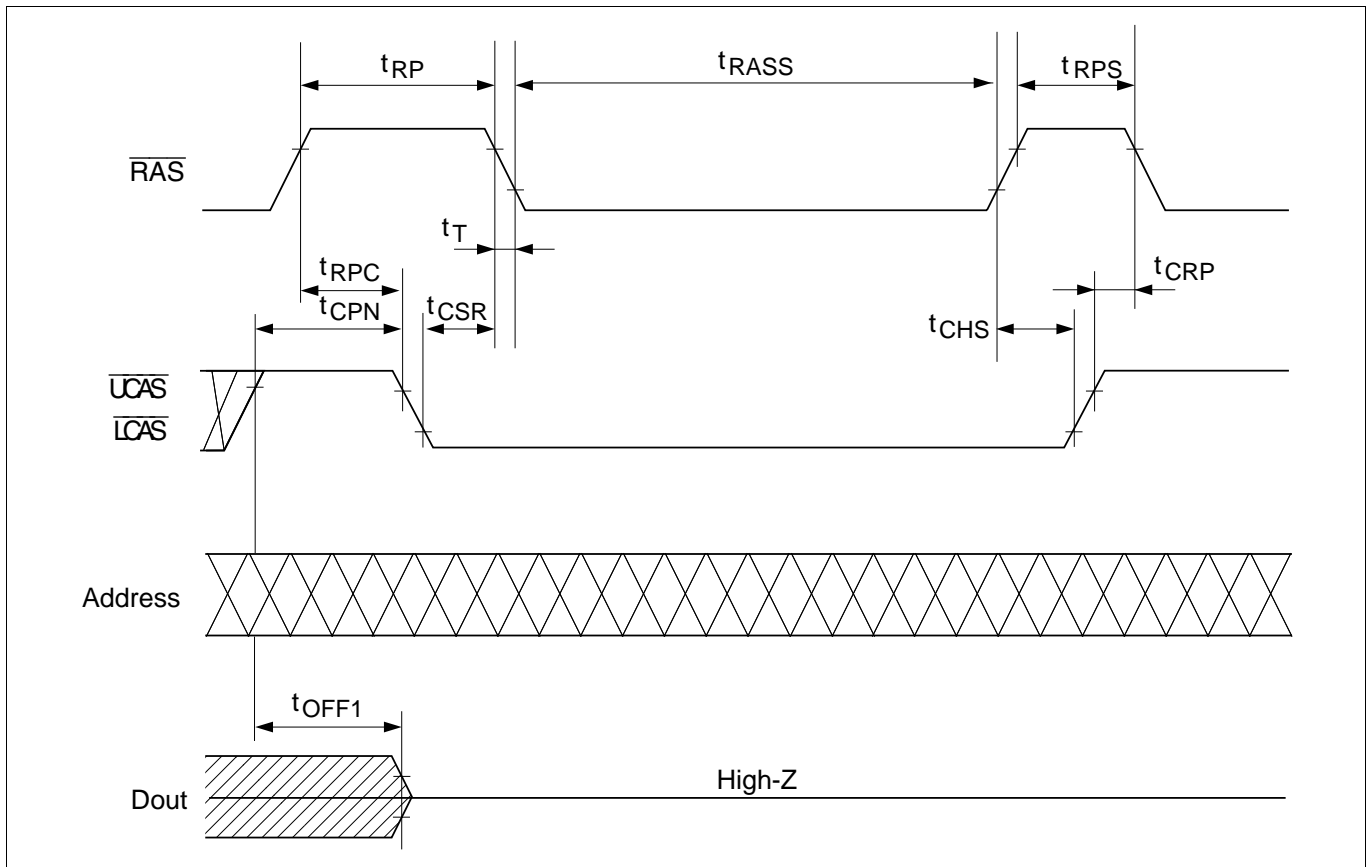


HM514265D Series, HM51S4265D Series

EDO Page Mode Mix Cycle (2)*24



Self Refresh Cycle *30, 31, 32, 33



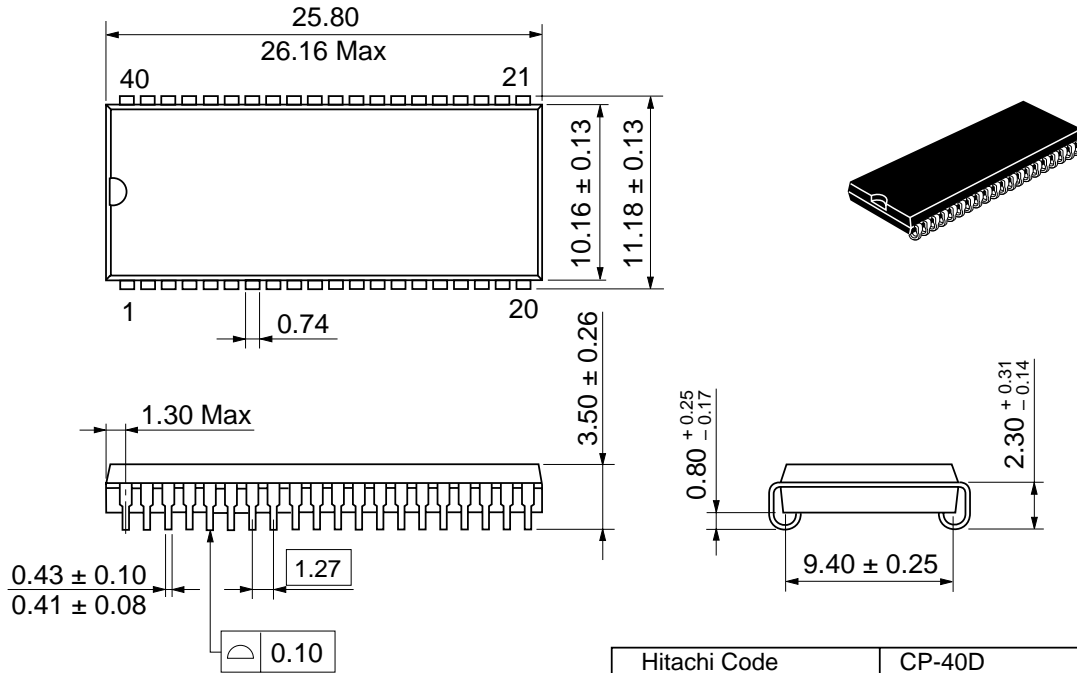
HM514265D Series, HM51S4265D Series

Package Dimension

HM514265DJ/DLJ Series

HM51S4265DJ/DLJ Series (CP-40D)

Unit: mm



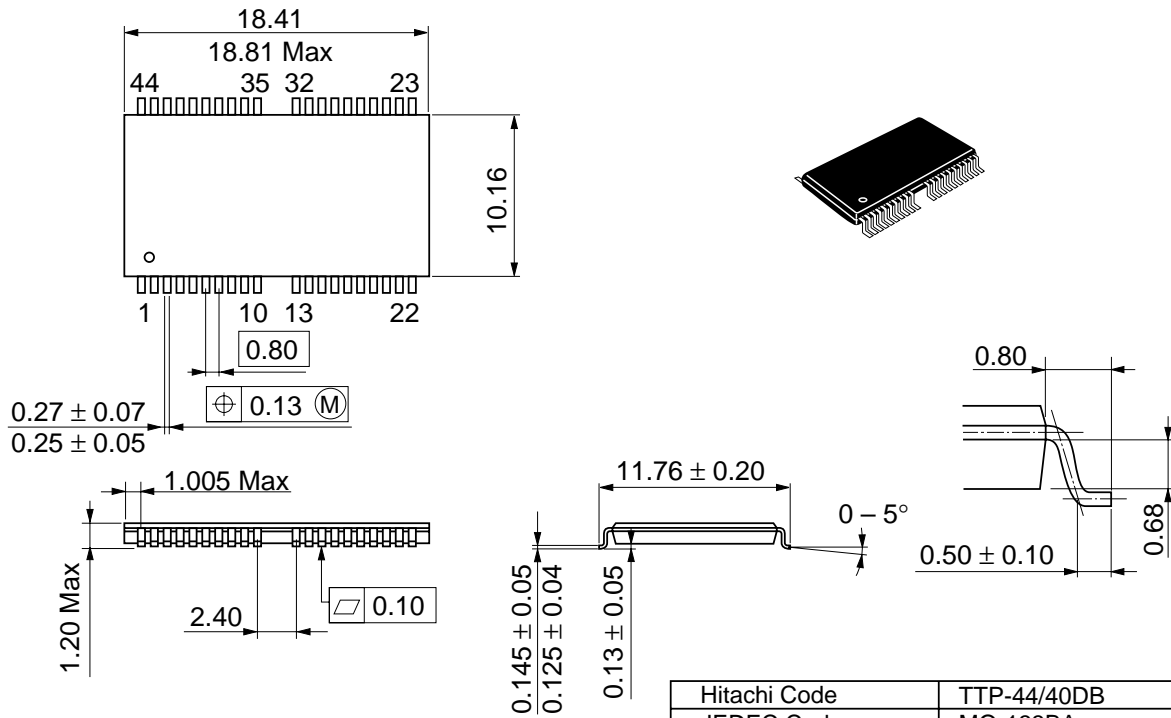
| | |
|--------------|--------|
| Hitachi Code | CP-40D |
| JEDEC Code | — |
| EIAJ Code | SC-640 |
| Weight | 1.73 g |

HM514265D Series, HM51S4265D Series

HM514265DTT/DLTT Series

HM51S4265DTT/DLTT Series (TTP-44/40DB)

Unit: mm



| | |
|--------------|-------------|
| Hitachi Code | TTP-44/40DB |
| JEDEC Code | MO-133BA |
| EIAJ Code | SC-504-8C |
| Weight | 0.43 g |

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Fax: 27306071

Revision Record

| Rev. | Date | Contents of Modification | Drawn by | Approved by |
|-------------|---------------|--|-----------------|--------------------|
| 0.0 | May. 20, 1996 | Initial issue | H. Hisakawa | S. Suzuki |
| 1.0 | Nov. 28, 1996 | Deletion of preliminary AC Characteristics Change of note 34 Addition of note 4 to Notes concerning $\overline{2CAS}$ control Timing Waveforms Deletion of notes about undefined pins | | |
